Search Notes

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SEARCHED

Class	Subclass	Date	Examiner
715	780, 781	1/22/08	PK
715	780, 781	7/6/08	PK
715	780, 781, 501, 513, 84-843, 790, 797, 853-855 and 760	1/4/09	PK
715	780, 781, 501, 513, 84-843, 790, 797, 853-855 and 760	7/17/09	PK

SEARCH NOTES

Search Notes	Date	Examiner
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT; USPUB; EPO; JPO; DERWENT)	1/22/08	PK
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT: USPUB: EPO: JPO: DERWENT)	7/6/08	PK
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT: USPUB: EPO: JPO: DERWENT)	1/4/09	PK
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT: USPUB: EPO; JPO; DERWENT)	7/17/09	PK

INTERFERENCE SEARCH

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